



**WANSEMI**  
万芯半导体

**WP3060AP3**

# Enhancement Mode N-Channel Power MOSFET

PDFN3X3/NMOS/30V/ $\pm 20$ V/1.9V/60A/3.8m $\Omega$

Rev0.6

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## 30V, 3.8mΩ, 60A, Single N-Channel

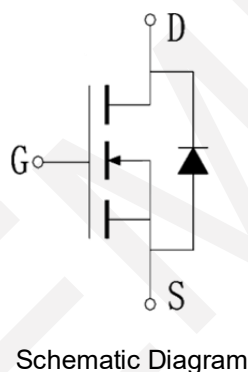
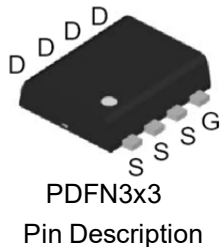
### 1.Features

- ◆ 30V MOSFET technology
- ◆ Low on-state resistance
- ◆ Fast switching
- ◆  $V_{GS} \pm 20V$

$V_{DS}$	$R_{DS(on)}$ Typ.	$I_D$ Max.
30V	3.8mΩ @ 10V	60A
	6.0mΩ @ 4.5V	

### 2.Applications

- ◆ Power Switching Application
- ◆ Load Switching



### 3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3060AP3	WP3060AP3	PDFN3X3	5,000	50,000

### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{DSS}$	30	V
Gate to Source Voltage	$V_{GSS}$	$\pm 20$	V
Drain Current (DC)	$I_D$	60	A
Drain Current (Pulse), $PW \leq 300\mu s$	$I_{DP}$	240	A
Total Dissipation	$P_D$	28	W
Avalanche Energy, Single Pulsed	$E_{AS}$	156	mJ
Junction Temperature	$T_j$	150	°C
Storage Temperature	$T_{stg}$	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

**5. Thermal Resistance Ratings (Note 2)**

Parameter	Symbol	Value	Unit
Junction to case	$R_{\theta JC}$	4.4	$^{\circ}\text{C/W}$

Note 2: When mounted on 1 inch square copper board  $t \leq 10\text{sec}$  The value in any given application depends on the user's specific board design.

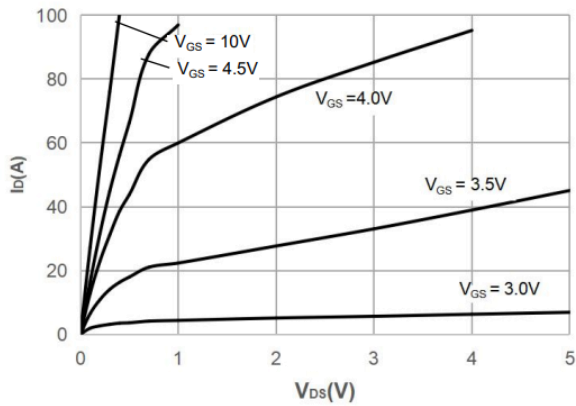
**6. Electrical Characteristics at  $T_a=25^{\circ}\text{C}$  (Note 3)**

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	$I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$	30			V
Zero-Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 30\text{V}$ , $V_{GS} = 0\text{V}$			1	$\mu\text{A}$
Gate to Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$			$\pm 100$	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}$ , $I_{DS}=250\mu\text{A}$	1.0	1.9	2.5	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	$I_D = 30\text{A}$ , $V_{GS} = 10\text{V}$		3.8	4.5	$\text{m}\Omega$
		$I_D = 20\text{A}$ , $V_{GS} = 4.5\text{V}$		6.0	8.0	$\text{m}\Omega$
Input Capacitance	$C_{iss}$	$V_{GS}=0\text{V}$ ,		2260		pF
Output Capacitance	$C_{oss}$	$V_{DS}=15\text{V}$ ,		296		pF
Reverse Transfer Capacitance	$C_{rss}$	Frequency=1.0MHz		230		pF
Turn-ON Delay Time	$t_{d(on)}$	$V_{DD} = 15\text{V}$ , $I_{DS} = 30\text{A}$ , $V_{GS} = 10\text{V}$ , $R_G = 3\Omega$		9		ns
Rise Time	$t_r$			15		ns
Turn-OFF Delay Time	$t_{d(off)}$			36		ns
Fall Time	$t_f$			11		ns
Total Gate Charge	$Q_g$	$V_{DS} = 15\text{V}$ , $V_{GS} = 10\text{V}$ , $I_{DS} = 15\text{A}$		42		nC
	$Q_{gs}$			9		nC
	$Q_{gd}$			10		nC
Diode Forward Voltage	$V_{FSD}$	$I_S = 30\text{A}$ , $V_{GS} = 0$			1.2	V

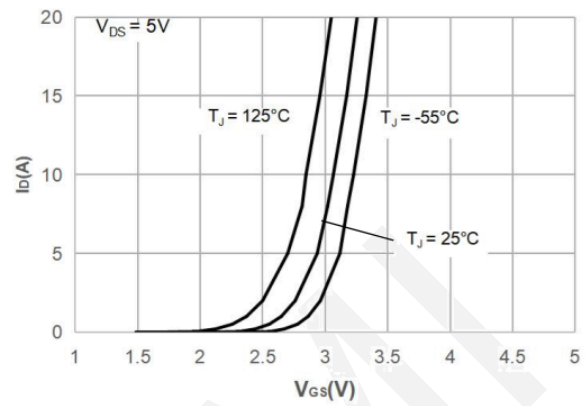
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



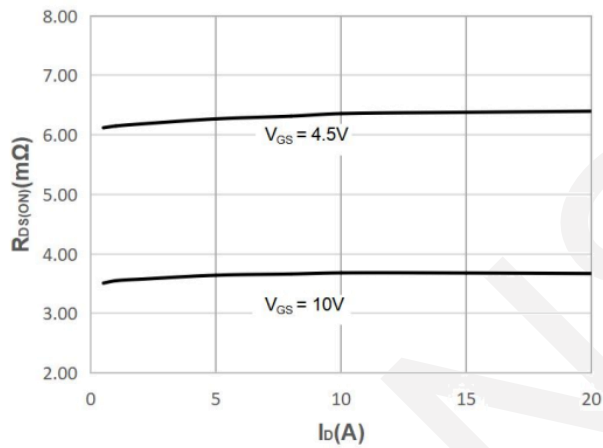
## 7. Typical electrical and thermal characteristics



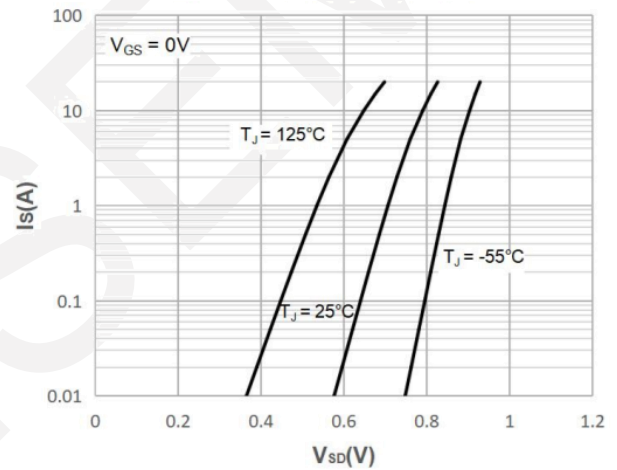
Output Characteristics



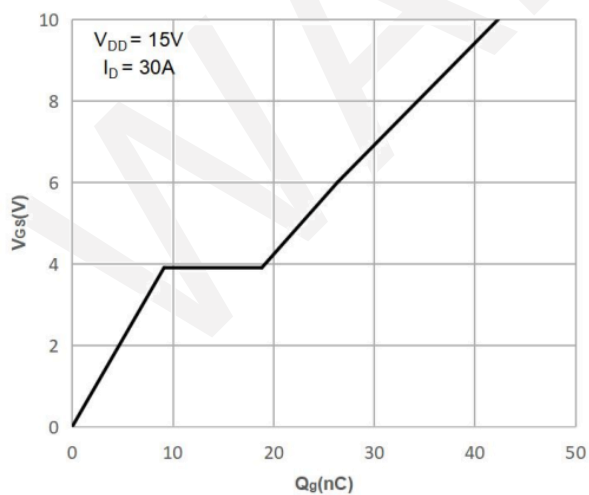
Typical Transfer Characteristics



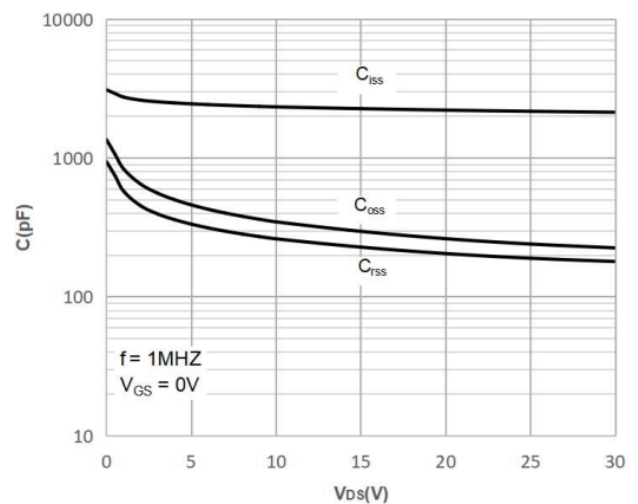
On-resistance vs. Drain Current



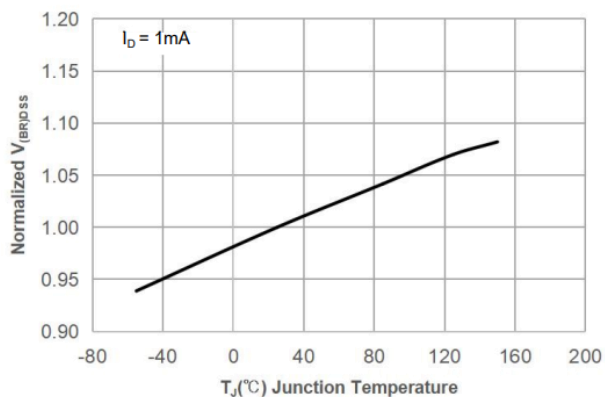
Body Diode Characteristics



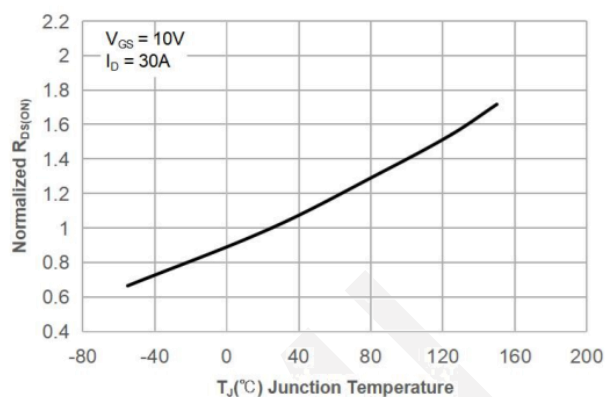
Gate Charge Characteristics



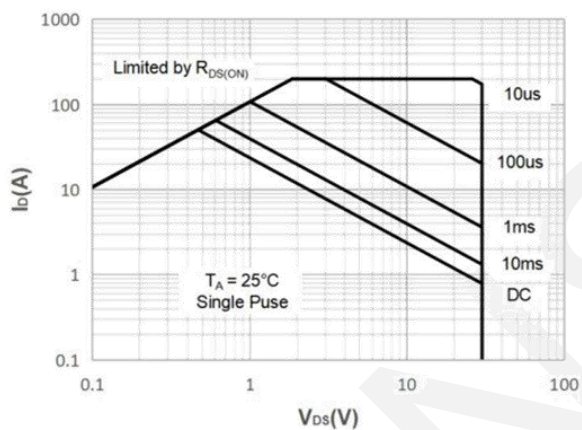
Capacitance Characteristics



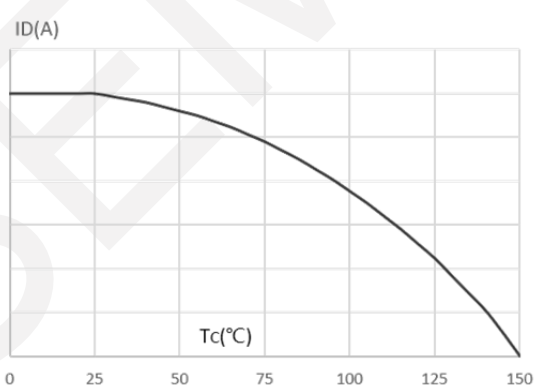
Normalized Breakdown Voltage vs.  
Junction Temperature



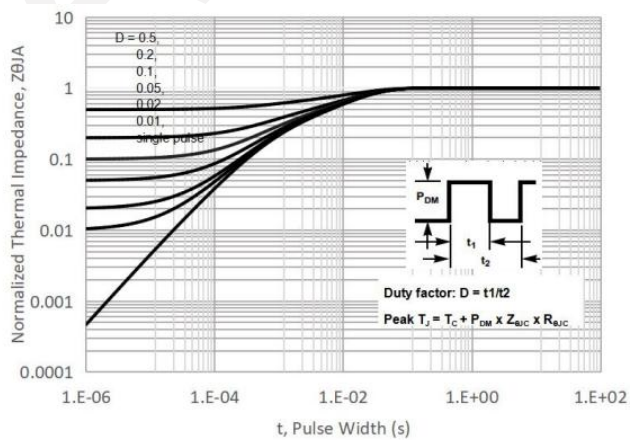
Normalized on Resistance vs.  
Junction Temperature



Maximum Safe Operating Area

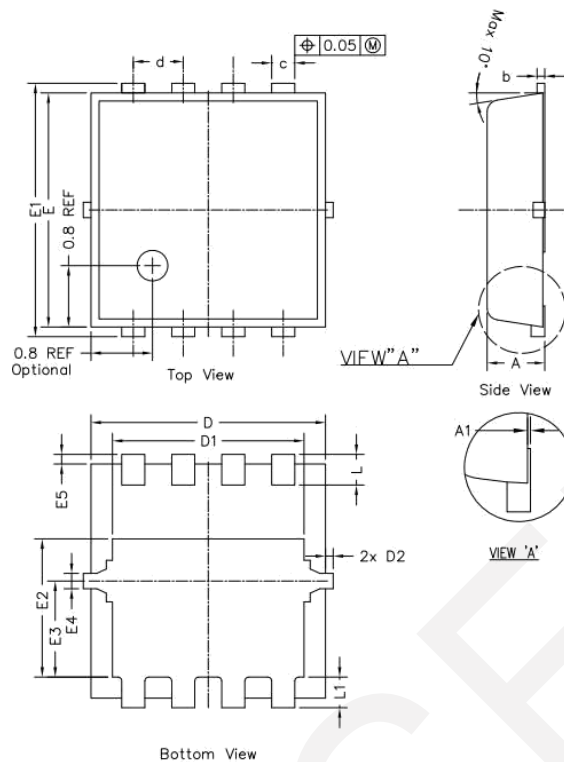


Maximum Continuous Drain Current vs.  
Case Temperature



Maximum Effective Transient Thermal  
Impedance, Junction-to-Case

## 8.Package Dimensions



SYMBOLS	DIMENSION IN MM			DIMENSION IN INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.700	0.750	0.800	0.028	0.030	0.031
A1	---	---	0.050	----	----	0.002
b	0.144	0.152	0.202	0.006	0.006	0.008
c	0.250	0.300	0.350	0.010	0.012	0.014
d	0.65 BSC			0.026 BSC		
D	2.950	3.050	3.150	0.116	0.120	0.124
D1	2.390	2.490	2.590	0.094	0.098	0.102
D2	---	---	0.125	---	---	0.005
E	2.950	3.050	3.150	0.116	0.120	0.124
E1	3.200	3.300	3.400	0.126	0.130	0.134
E2	1.700	1.800	1.900	0.067	0.071	0.075
E3	1.150	1.250	1.350	0.045	0.049	0.053
E4	0.150	0.200	0.250	0.006	0.008	0.010
E5	0.075	0.125	0.175	0.003	0.005	0.007
L	0.300	0.400	0.500	0.01	0.02	0.02
L1	0.300	0.400	0.500	0.01	0.02	0.02

## 9. Important Notice

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